## Notice of References Cited Application/Control No. 10/664,483 Examiner Dilek B. Cobanoglu Applicant(s)/Patent Under Reexamination BECERRA ET AL. Art Unit Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,170,742 B1	01-2001	Yacoob, Yaser	235/375
*	В	US-2002/0010613 A1	01-2002	Lallo, Jeffrey Todd Di	705/8
*	C	US-2002/0010599 A1	01-2002	Levison, Michael D.	705/4
*	D	US-2002/0016655 A1	02-2002	Joao, Raymond Anthony	701/35
*	E	US-2002/0116281 A1	08-2002	Costello et al.	705/26
*	F	US-2002/0165741 A1	11-2002	Becker et al.	705/4
*	G	US-2003/0061104 A1	03-2003	Thomson et al.	705/26
	Н	US-			
	1	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	α					
	R					
	S					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
	υ						
	٧						
	w						
	×						

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.